

AONV070V65G1

650V Enhancement Mode GaN Transistor

Features

- 650V Enhancement Mode GaN Transistor
- Normal-off Design
- Ultra-low Qg
- No Qrr
- Low Inductance

Applications

- Server Power Supplies
- High-Frequency Converters
- Resonant Topologies

Product Summary

 $\begin{array}{lll} V_{DS} @ T_{J}, max & 650V \\ I_{DM} & 45A \\ R_{DS(ON)} & 70m\Omega \\ Q_{g}, typ & 6.9nC \\ E_{oss} @ 400V & 6\mu J \end{array}$



Pin Configuration and Pin Names

DFN 8x8		Pin Names		D
8	5	Gate	8	O 1, 2, 3, 4
5		Drain	1, 2, 3, 4]
	TP 8	Kelvin Source	7	8
	4	Source	5, 6	SK 0
4	1	Thermal Pad	TP	7 0 5, 6
Top View	Bottom View	(Connected to Source)		s

Absolute Maximum Ratings

Exceeding the Absolute Maximum Ratings may damage the device. $T_A = 25$ °C, unless otherwise stated.

Symbol	Parameter	Maximum	Units	
V _{DS}	Drain-Source Voltage		650 (DC) 720 (AC)	V
V _{GS}	Gate-Source Voltage		+6 / -4 (DC) +10 / -10 (AC)	V
I _D	Continuous Drain Current	T _A = 25°C T _A = 100°C	16 ⁽¹⁾ 12 ⁽¹⁾	Α
P _D	Power Dissipation ⁽²⁾	Derate above 25°C	125	W
T _J , T _{STG}	Junction and Storage Temperature Range		-55 to 150	°C
T _L	Maximum Lead and Temperature for Soldering		260	°C

Thermal Characteristics

Symbol	Parameter	Maximum	Units
$R_{JC\theta}$	Maximum Junction-to-Case	1	°C/W
$R_{JA\theta}$	Maximum Junction-to-Ambient ⁽³⁾	65	°C/W



Electrical Characteristics

 $T_A = 25$ °C, $V_{IN} = V$, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC							
\/	Drain Source Voltage	DC static V _{DS} (max)				650	V
$V_{DS(max)}$	Drain-Source Voltage	AC transient _{VDS} (max)				720	'
1	Zero Gate Voltage Drain Current	V _{DS} =650V, V _{GS} =0V			0.5		μΑ
I _{DSS}	Zero Gate voltage Drain Gurrent		T _J =150°C		5		μΑ
I_{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =6V			100		μΑ
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} =5V, I_{D} =5mA		1.1	1.8	2.3	V
Raccoun	Static Drain-Source On-Resistance	V_{GS} =6V, I_D =6A	ì		70	90	mΩ
R _{DS(ON)}	Static Drain-Source Off-Nesistance		$T_J = 150$ °C		165		
V _{SD}	Diode Forward Voltage	I _S =10A,V _{GS} =0V			2.3		V
DYNAMIC							
C _{iss}	Input Capacitance	- V _{GS} =0V, V _{DS} =400V, f=1MHz			203		pF
C _{oss}	Output Capacitance				58		pF
C _{o(er)}	Effective Output Capacitance, Energy Related ⁽⁴⁾	─ V _{GS} =0V, V _{DS} =0 to 400V, f=1MHz			74		pF
C _{o(tr)}	Effective Output Capacitance, Time Related ⁽⁵⁾				105		pF
C _{rss}	Reverse Transfer Capacitance	V _{GS} =0V, V _{DS} =400V, f=1MHz			1.5		pF
R _g	Gate Resistance	f=1MHz			10		Ω
SWITCHIN	IG						
Qg	Total Gate Charge				6.9		nC
Q _{gs}	Gate Source Charge	V_{GS} =6V, V_{DS} =400V, I_{D} =	6A		2		nC
Q _{gd}	Gate Drain Charge				1.4		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =-3V/+6V, V_{DS} =400V, I_{D} =6A, $R_{G,ON}$ =4.7 Ω , $R_{G,OFF}$ =1 Ω			2.4		ns
t _r	Turn-On Rise Time				5.4		ns
t _{D(off)}	Turn-Off DelayTime				6.2		ns
t _f	Turn-Off Fall Time				14.2		ns
Q _{rr}	Body Diode Reverse Recovery Charge	IF=6A, dI/dt=100A/ms, V _{DS} =400V			0		nC
Q _{oss}	Output Charge	IF=6A, dI/dt=100A/ms, V _{DS} =400V			42		nC

Notes:

- Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C, Ratings are based on low frequency and duty cycles to keep initial T_J =25°C.
- The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. The value of R $_{\theta JA}$ is measured with the device in a still air environment with T $_A$ =25°C.
- 4. $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$.
- 5. $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$
- These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a
 maximum junction temperature of T_{J(MAX)}=150°C.
- 7. The static characteristics in Figures 1 to 7 are obtained using <300ms pulses, duty cycle 0.5% max.

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Typical Characteristics

 T_A = 25 °C, V_{IN} = V, unless otherwise specified

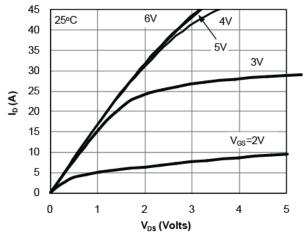


Figure 1. On-Region Characteristics

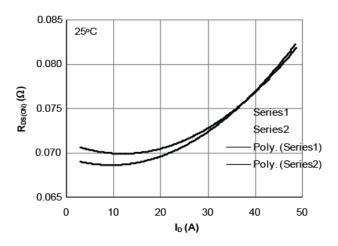


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

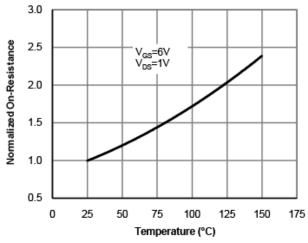


Figure 5. On-Resistance vs. Junction Temperature

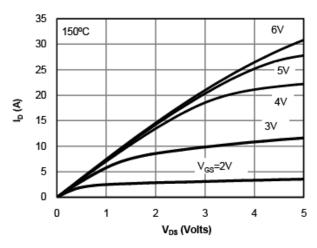


Figure 2. High Temperature On-Region

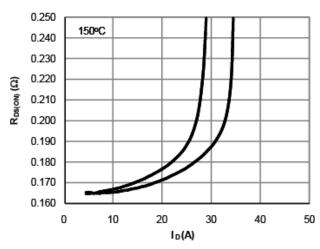


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

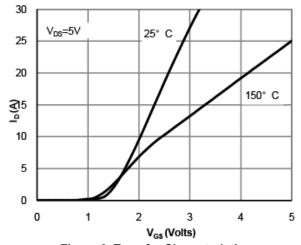


Figure 6. Transfer Characteristics



Typical Characteristics

 T_A = 25 °C, V_{IN} = V, unless otherwise specified

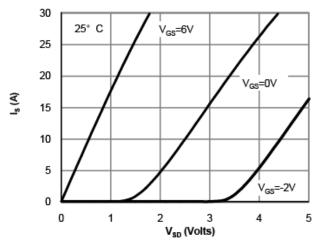


Figure 7. Body-Diode Characteristics

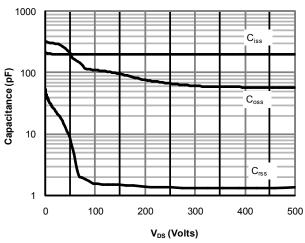


Figure 9. Capacitance Characteristics

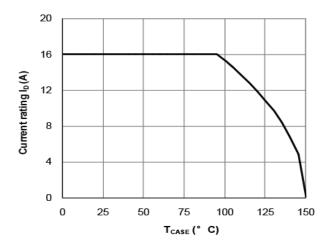


Figure 11. Current De-rating (Note 6)

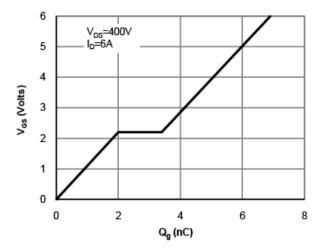


Figure 8. Gate-Charge Characteristics

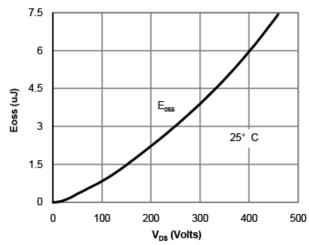


Figure 10. Coss Stored Energy



Typical Characteristics

 T_A = 25 °C, V_{IN} = V, unless otherwise specified

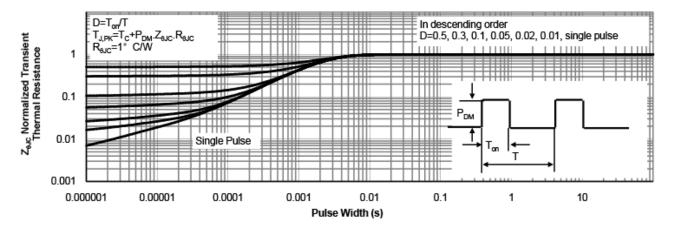
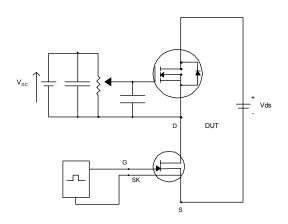


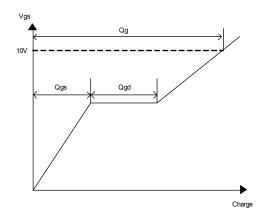
Figure 12. Normalized Maximum Transient Thermal Impedance for TO-220F Pb Free (Note 6)



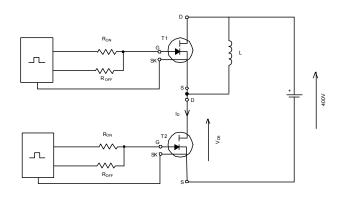
Test Circuits and Waveforms

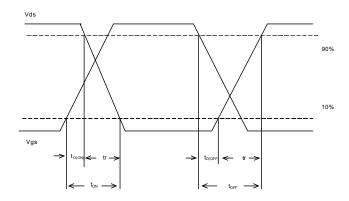
Gate Charge Test Circuit & Waveforms





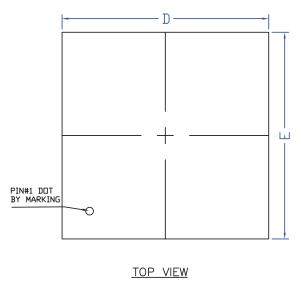
Resistive Switching Test Circuit & Waveforms

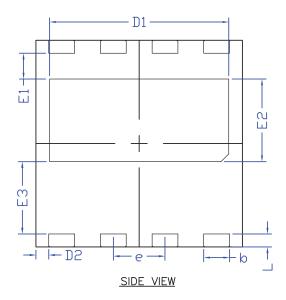


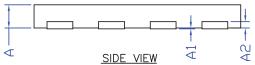




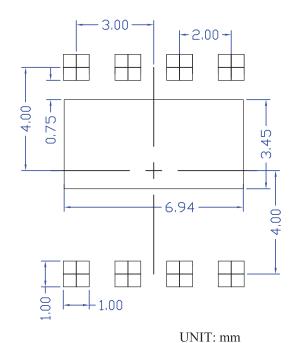
Package Dimensions, DFN8x8-8L







RECOMMENDED LAND PATTERN



	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SYMBOLS	MIN	NOM	MAX	MIN	MON	MAX	
Α	0.800		1.100	0.031		0.043	
A1	0.000		0.050	0.000		0.002	
A2	0.150	0.250	0.350	0.006	0.010	0.014	
b	0.900	1.000	1.100	0.035	0.039	0.043	
D	7.900	8.000	8.100	0.311	0.315	0.319	
D1	6.840	6.940	7.040	0.269	0.273	0.277	
D2	0.400	0.500	0.600	0.016	0.020	0.024	
E	7.900	8.000	8.100	0.311	0.315	0.319	
E1	0.900	1.000	1.100	0.035	0.039	0.043	
E2	3.100	3.200	3.300	0.122	0.126	0.130	
E3	2.700	2.800	2.900	0.106	0.110	0.114	
е	2.00 B.S.C.				0.079 B.S.C		
L	0.400	0.500	0.600	0.016	0.020	0.024	

NOTE

CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

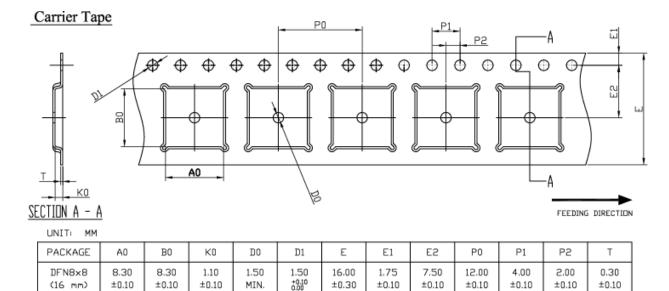
±0.10

±0.10

±0.10



Tape and Reel, DFN8x8-8L



±0.30

±0.10

±0.10

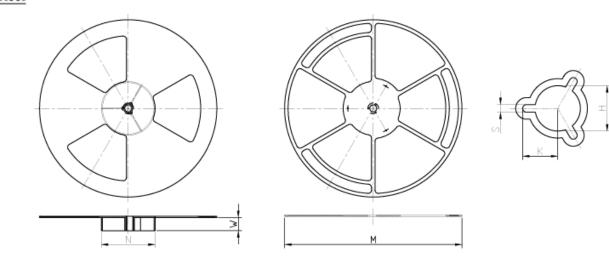
Reel

±0.10

±0.10

±0.10

MIN.

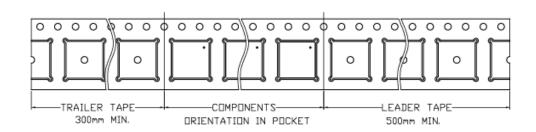


UNIT:	MM

TAPE SIZE	REEL SIZE	М	N	W	Н	К	S
16 mm	ø330	Ø330.00 MAX.	Ø100.00 MIN.	16.4 +2.0 -0.0	Ø13.0 +0.5 -0.2	10.1 MIN.	1.5 MIN.

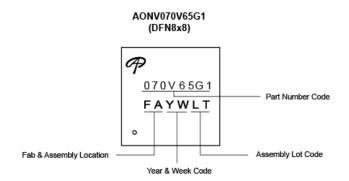
Tape

Leader / Trailer & Orientation





Part Marking



PART NO.	DESCRIPTION	CODE	
AONV070V65G1	Green product	070V65G1	

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